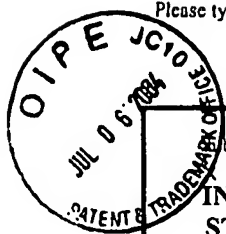


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Application Number		10/728,731			
Filing Date		December 4, 2003			
First Named Inventor		TSOUGARAKIS et al.			
Group Art Unit		3731			
Examiner Name					
Attorney Docket Number		6700-0012 (CI02-U07.US1)			
Sheet	1	of	1		

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY
		Number	Kind Code ² (if known)		
/AT/	A1	5,671,741		Lang et al.	09-30-1997
/AT/	A2	6,219,571	B1	Hargreaves et al.	04-17-2001
/AT/	A3	2002/0087274	A1	Alexander et al.	07-04-2002
/AT/	A4	6,479,996	B1	Hoogeveen et al.	11-12-2002

FOREIGN PATENT DOCUMENTS							
Examiner Initials*	Cite No. ¹	Foreign Patent Document			Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	T ⁶
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/AT/	B1	WO	02/22014		Leland Stanford Junior University	03-21-2002	

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS					
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			T ⁶
/AT/	C1	MRI BASIC PRINCIPLES AND APPLICATIONS, Second Ed., Mark A Brown and Richard C. Semelka, 1999, Wiley-Liss Inc., Title page and Table of Contents pages only (ISBN 0471330620)			

Examiner Signature	/Abolfazl Tabatabai/	Date Considered	07/31/2007
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Unique citation designation number.

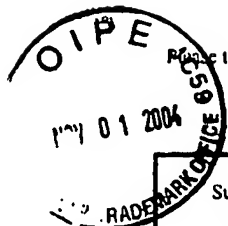
² See attached Kinds of U.S. Patent Documents.

³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3).

⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document.

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Sheet	1	of	1	Examiner Name	
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OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ⁶
/AT/	C1	Tamez-Pena, J. et al., "MRI ISOTROPIC RESOLUTION RECONSTRUCTION FROM TWO ORTHOGONAL SCANS," Proceedings of the SPIE - The International Society for Optical Engineering SPIE-INT. Vol. 4322, pp. 87-97, 2001.	

Examiner Signature	/Abolfazl Tabatabai/	Date Considered	07/31/2007
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